

SWITCHING REGULATOR APPLICATIONS

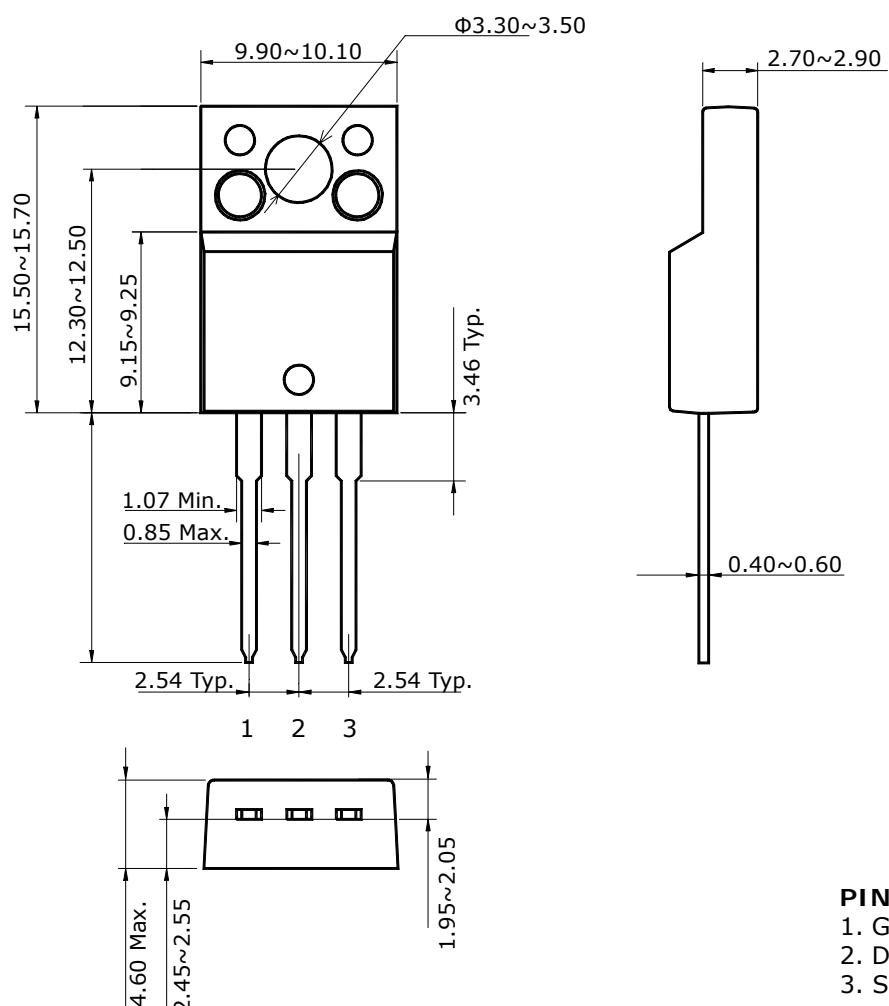
Features

- High Voltage: $BV_{DSS}=600V$ (Min.)
- Low C_{rss} : $C_{rss}=5.8pF$ (Typ.)
- Low gate charge : $Qg=13nC$ (Typ.)
- Low $R_{DS(on)}$: $R_{DS(on)}=2.5\Omega$ (Max.)

Ordering Information

Type NO.	Marking	Package Code
SMK0460F	SMK0460	TO-220F-3L

Outline Dimensions

unit : mm


Absolute maximum ratings

(Tc=25°C)

Characteristic	Symbol	Rating	Unit
Drain-source voltage	V _{DSS}	600	V
Gate-source voltage	V _{GSS}	±30	V
Drain current (DC)	I _D	(Tc=25°C)	4
		(Tc=100°C)	2.53
Drain current (Pulsed) *	I _{DM}	16	A
Drain Power dissipation	P _D	30	W
Avalanche current (Single) ②	I _{AS}	4	A
Single pulsed avalanche energy ②	E _{AS}	225	mJ
Avalanche current (Repetitive) ①	I _{AR}	4	A
Repetitive avalanche energy ①	E _{AR}	10	mJ
Junction temperature	T _J	150	°C
Storage temperature range	T _{stg}	-55~150	

* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max	Unit
Thermal resistance	R _{th(J-C)}	-	4.16	°C/W
	R _{th(J-a)}	-	62.5	

Electrical Characteristics

(Tc=25°C)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV _{DSS}	I _D =250μA, V _{GS} =0	600	-	-	V
Gate-threshold voltage	V _{GS(th)}	I _D =250μA, V _{DS} = V _{GS}	2.0	-	4.0	V
Drain-source leakage current	I _{DSS}	V _{DS} =600V, V _{GS} =0V	-	-	1	μA
Gate-source leakage	I _{GSS}	V _{DS} =0V, V _{GS} =±30V	-	-	±100	nA
Drain-Source on-resistance ④	R _{DS(ON)}	V _{GS} =10V, I _D =2.0A	-	2.1	2.5	Ω
Forward transfer admittance ④	g _{fs}	V _{DS} =10V, I _D =2.0A	-	4.0	-	S
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V, f=1MHz	-	592	789	pF
Output capacitance	C _{oss}		-	54	72	
Reverse transfer capacitance	C _{rss}		-	5.8	7.7	
Turn-on delay time	t _{d(on)}	V _{DD} =300V, I _D =4A R _G =25Ω	-	10	-	ns
Rise time	t _r		-	42	-	
Turn-off delay time	t _{d(off)}		-	38	-	
Fall time	t _f		-	46	-	
Total gate charge	Q _g	V _{DS} =480V, V _{GS} =10V I _D =4A	-	13	17	nC
Gate-source charge	Q _{gs}		-	4	-	
Gate-drain charge	Q _{gd}		(3)(4)	-	3	-

Source-Drain Diode Ratings and Characteristics

(Tc=25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Continuous source current	I _S	Integral reverse diode in the MOSFET	-	-	4	A
Source current (Pulsed) ①	I _{SM}		-	-	16	
Forward voltage ④	V _{SD}	V _{GS} =0V, I _S =4A	-	-	1.4	V
Reverse recovery time	t _{rr}	I _s =4A di _s /dt=100A/us	-	300	-	ns
Reverse recovery charge	Q _{rr}		-	2.2	-	uC

Note :

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ② L=25.9mH, I_{AS}=4A, V_{DD}=50V, R_G=27Ω , Starting T_J = 25 °C
- ③ Pulse Test : Pulse Width < 300us, Duty cycle≤ 2%
- ④ Essentially independent of operating temperature

Electrical Characteristic Curves

Fig. 1 I_D - V_{DS}

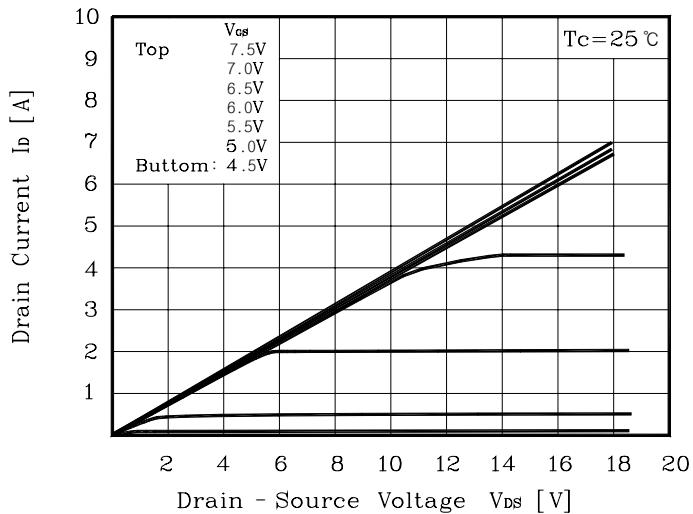


Fig. 2 I_D - V_{GS}

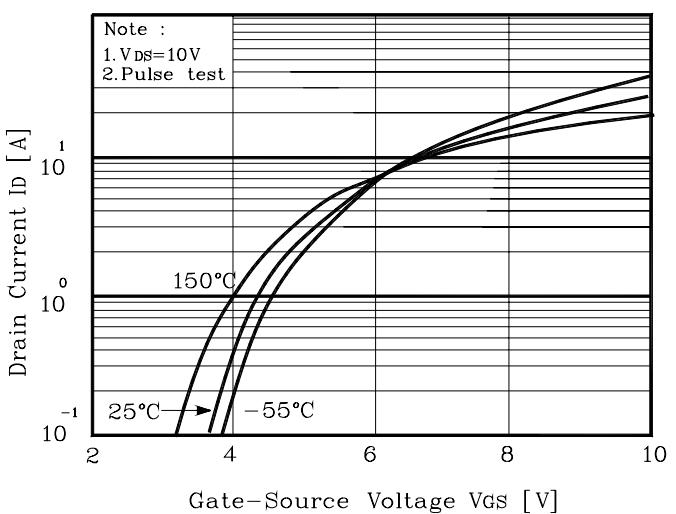


Fig. 3 $R_{DS(on)}$ - I_D

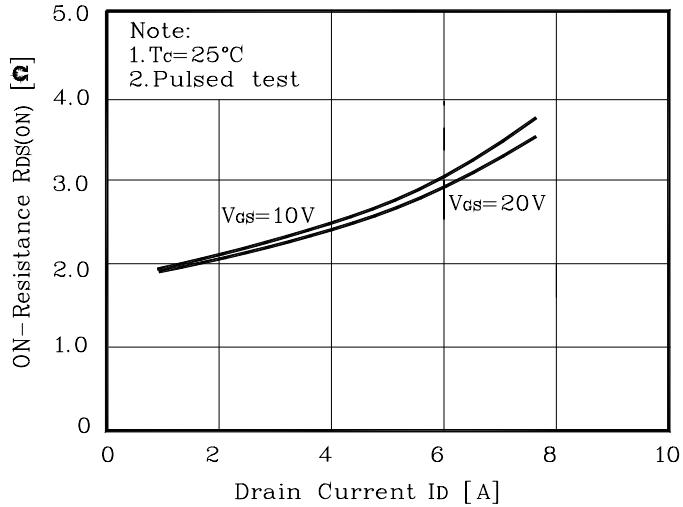


Fig. 4 I_S - V_{SD}

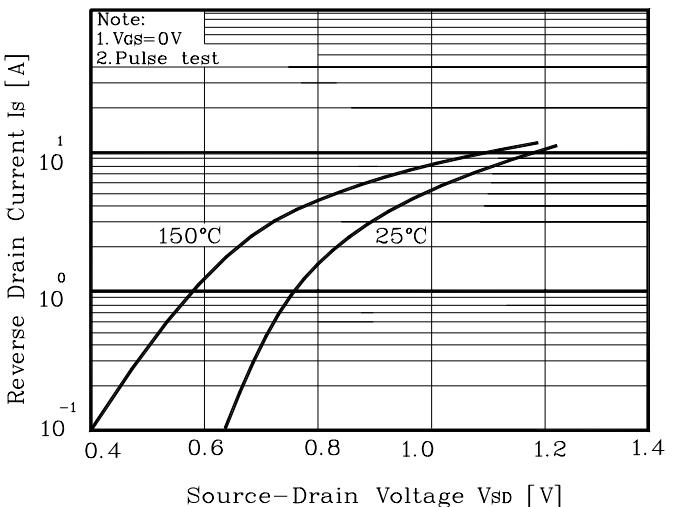


Fig. 5 Capacitance - V_{DS}

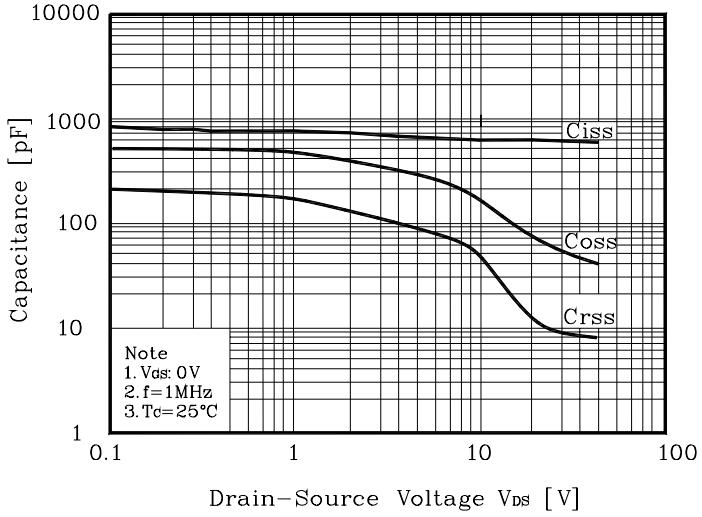
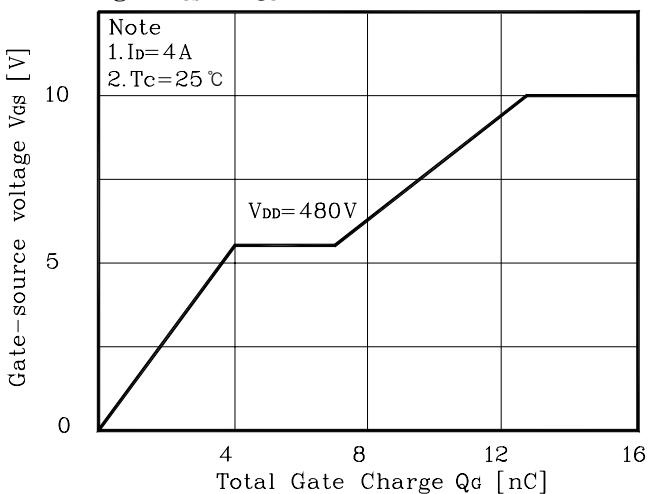


Fig. 6 V_{GS} - Q_G



Electrical Characteristic Curves

Fig. 7 V_{DSS} - T_J

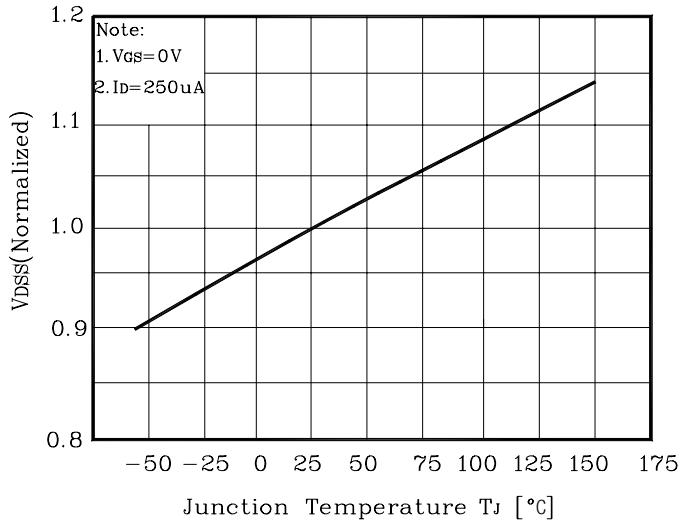


Fig. 8 $R_{DS(on)}$ - T_J

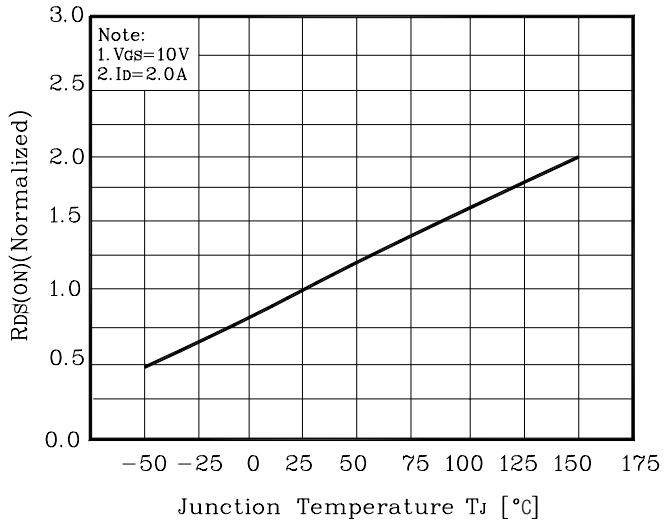


Fig. 9 I_D - T_c

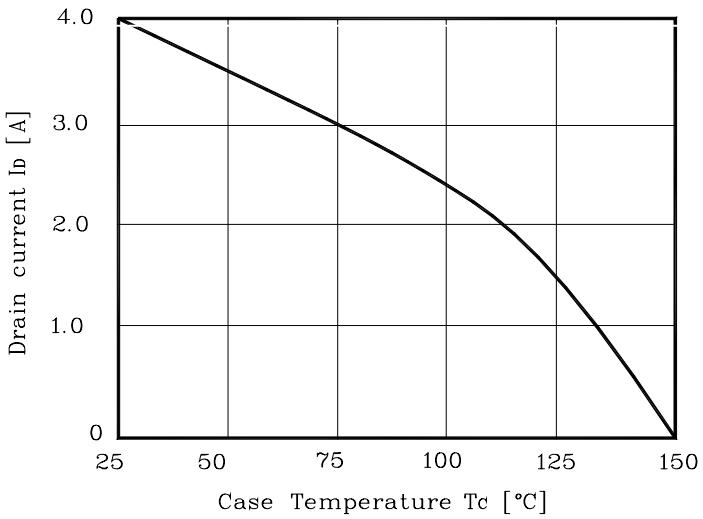


Fig. 10 Safe Operating Area

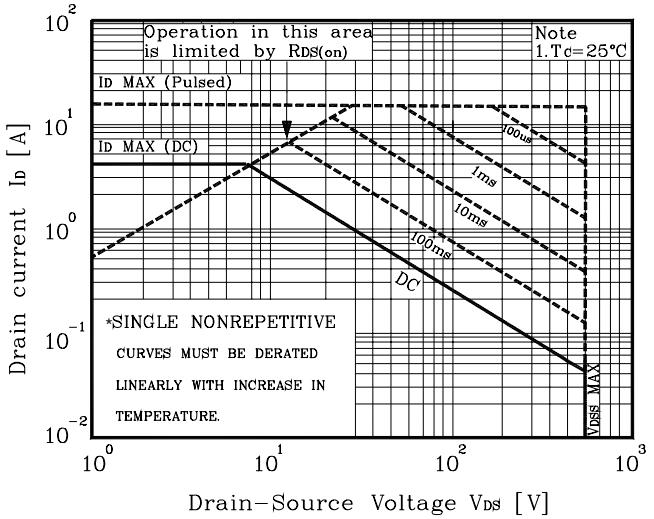


Fig. 11 Gate Charge Test Circuit & Waveform

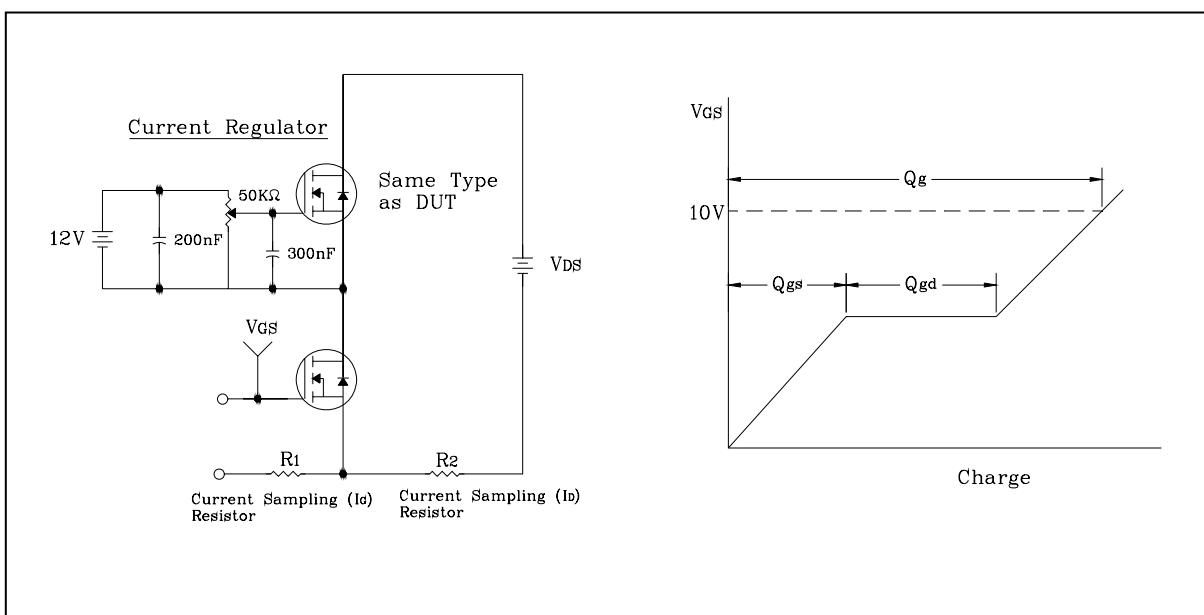


Fig. 12 Resistive Switching Test Circuit & Waveform

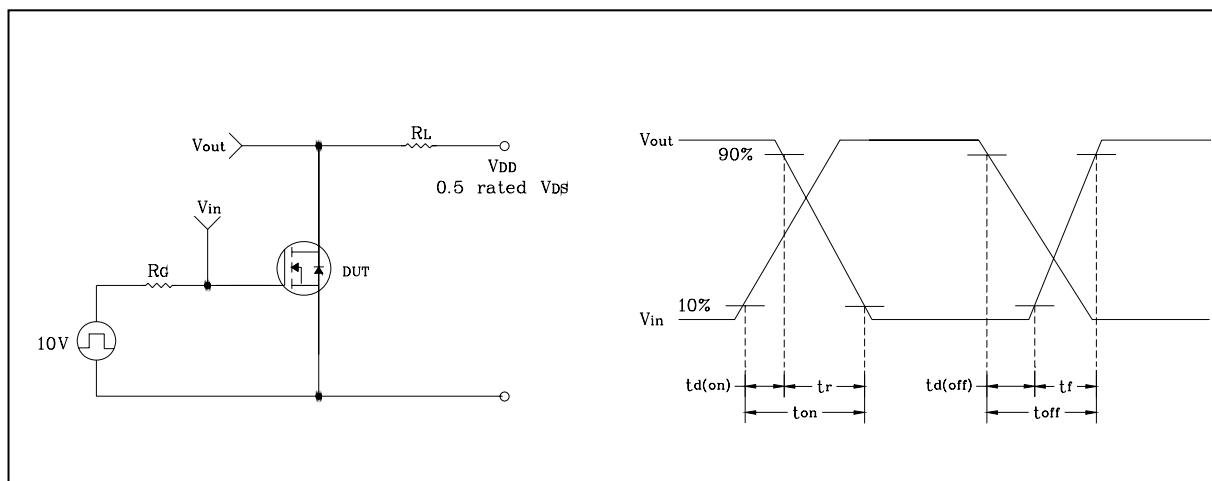


Fig. 13 E_{AS} Test Circuit & Waveform

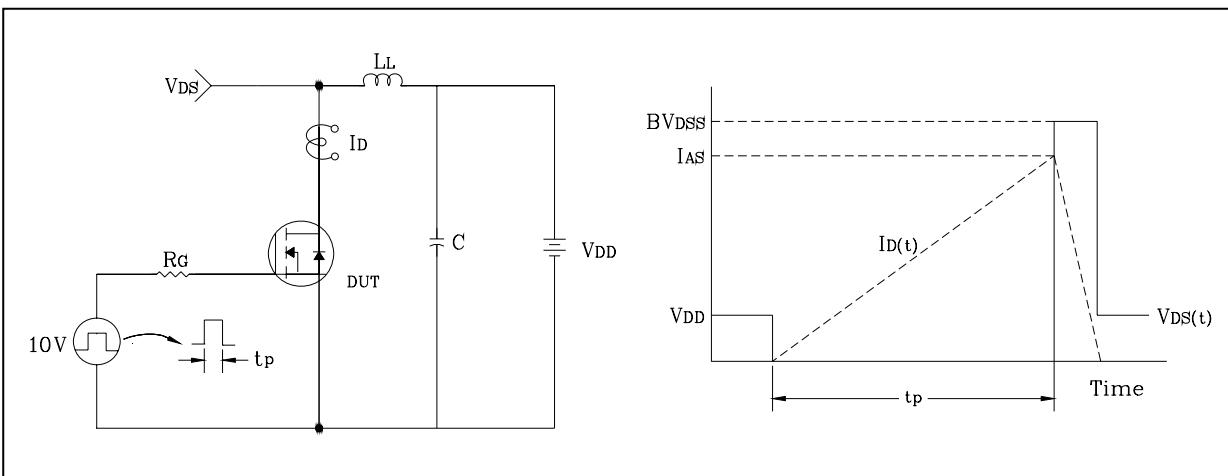
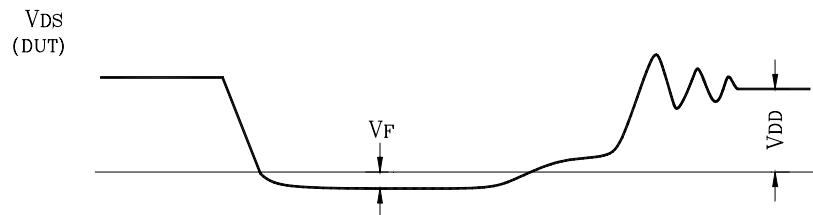
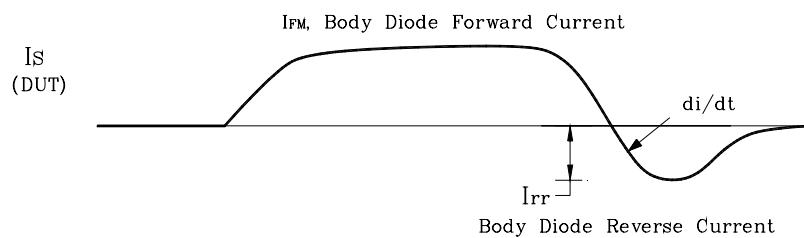
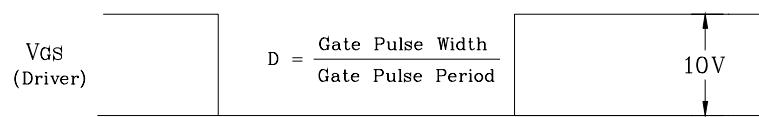
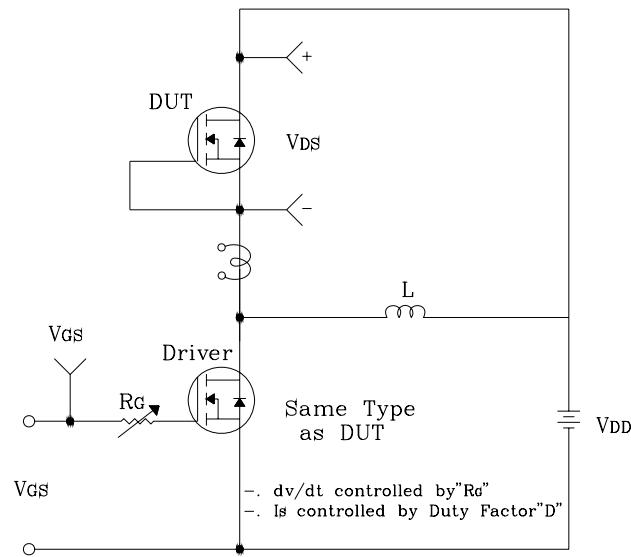


Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform



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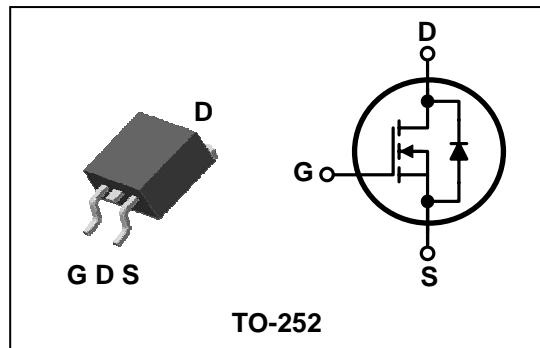
SWITCHING REGULATOR APPLICATIONS

Features

- High Voltage: $BV_{DSS}=600V$ (Min.)
- Low C_{rss} : $C_{rss}=3.4\text{pF}$ (Typ.)
- Low gate charge : $Q_g=7.0\text{nC}$ (Typ.)
- Low $R_{DS(on)}$: $R_{DS(on)}=4.7\Omega$ (Max.)

Ordering Information

Type No.	Marking	Package Code
SMK0260D	SMK0260	TO-252

PIN Connection

Absolute maximum ratings ($T_c=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol		Rating	Unit
Drain-source voltage	V_{DSS}		600	V
Gate-source voltage	V_{GSS}		± 30	V
Drain current (DC) *	I_D	$T_c=25^\circ\text{C}$	2.0	A
		$T_c=100^\circ\text{C}$	1.35	A
Drain current (Pulsed) *	I_{DM}		8.0	A
Drain power dissipation	P_D		48	W
Avalanche current (Single) ②	I_{AS}		2.0	A
Single pulsed avalanche energy ②	E_{AS}		130	mJ
Avalanche current (Repetitive) ①	I_{AR}		2.0	A
Repetitive avalanche energy ①	E_{AR}		5.6	mJ
Junction temperature	T_J		150	$^\circ\text{C}$
Storage temperature range	T_{stg}		-55~150	$^\circ\text{C}$

* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max	Unit
Thermal resistance	$R_{th(J-C)}$	-	2.6	$^\circ\text{C}/\text{W}$
	$R_{th(J-A)}$	-	62.5	

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$I_D=250 \mu\text{A}, V_{GS}=0\text{V}$	600	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$I_D=250 \mu\text{A}, V_{GS}=V_{DS}$	2.0	-	4.0	V
Drain-source cut-off current	I_{DSS}	$V_{DS}=600\text{V}, V_{GS}=0\text{V}$	-	-	1	μA
		$V_{DS}=600\text{V}, V_{GS}=0\text{V}, T_C=125^\circ\text{C}$			200	
Gate leakage current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$	-	-	± 100	nA
Drain-source on-resistance ⁽⁴⁾	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=1.0\text{A}$	-	3.9	4.7	Ω
Forward transfer conductance ⁽⁴⁾	g_{fs}	$V_{DS}=10\text{V}, I_D=1.0\text{A}$	-	5	-	S
Input capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$ $f=1 \text{ MHz}$	-	250	334	pF
Output capacitance	C_{oss}		-	20	27	
Reverse transfer capacitance	C_{rss}		-	3.4	4.6	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=300\text{V}, I_D=2.0\text{A}$ $R_G=25\Omega$	-	9	-	ns
Rise time	t_r		-	25	-	
Turn-off delay time	$t_{d(off)}$		-	24	-	
Fall time	t_f		-	28	-	
Total gate charge	Q_g	$V_{DS}=480\text{V}, V_{GS}=10\text{V}$ $I_D=2.0\text{A}$	-	7.0	9.5	nC
Gate-source charge	Q_{gs}		-	1.5	-	
Gate-drain charge	Q_{gd}		-	4.7	-	

Source-Drain Diode Ratings and Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Source current (DC)	I_S	Integral reverse diode in the MOSFET	-	-	2.0	A
Source current (Pulsed) ⁽¹⁾	I_{SP}		-	-	8.0	
Forward voltage ⁽⁴⁾	V_{SD}	$V_{GS}=0\text{V}, I_S=2.0\text{A}$	-	-	1.4	V
Reverse recovery time	t_{rr}	$I_S=2.0\text{A}, V_{GS}=0\text{V}$ $dI_S/dt=100\text{A}/\mu\text{s}$	-	230	-	ns
Reverse recovery charge	Q_{rr}		-	1.0	-	μC

Note :

- ① Repetitive rating : Pulse width limited by maximum junction temperature
- ② $L=59.5\text{mH}, I_{AS}=2.0\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$, Starting $T_J = 25^\circ\text{C}$
- ③ Pulse Test : Pulse width $\leq 300 \mu\text{s}$, Duty cycle $\leq 2\%$
- ④ Essentially independent of operating temperature

Electrical Characteristic Curves

Fig. 1 I_D - V_{DS}

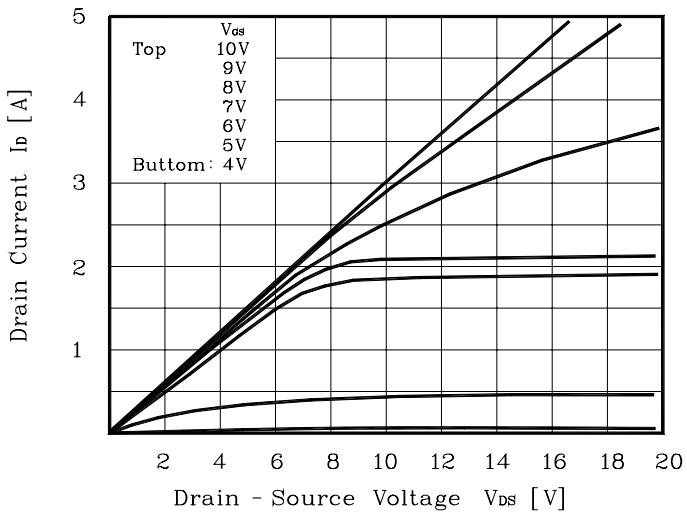


Fig. 2 I_D - V_{GS}

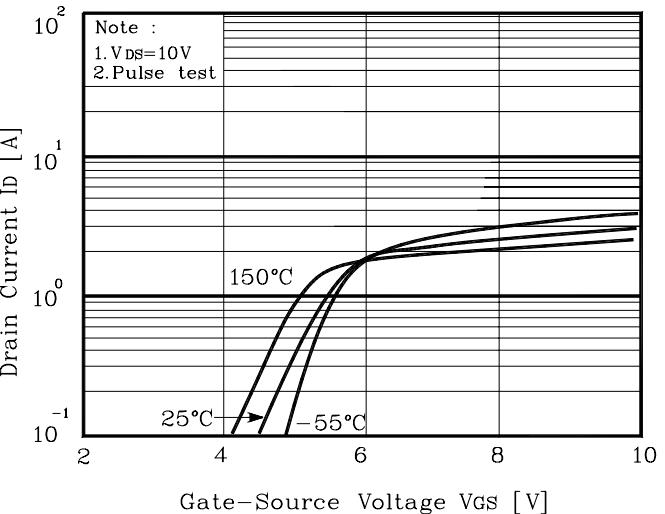


Fig. 3 $R_{DS(on)}$ - I_D

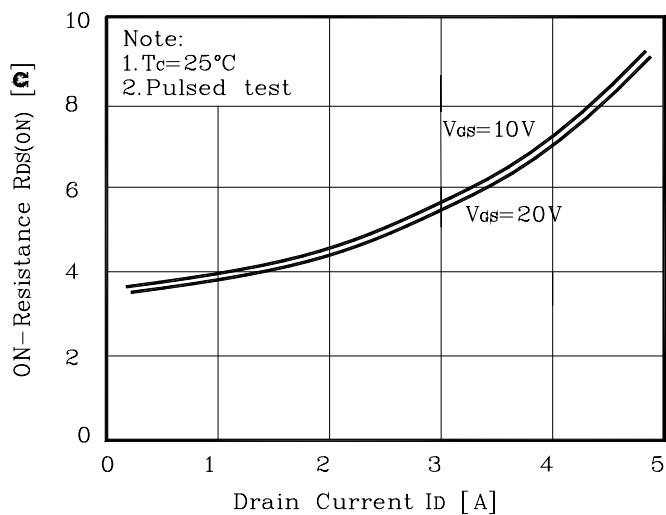


Fig. 4 I_S - V_{SD}

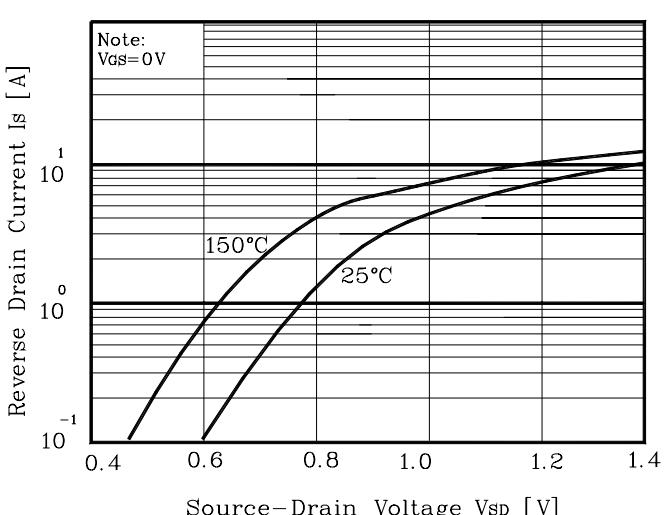


Fig. 5 Capacitance - V_{DS}

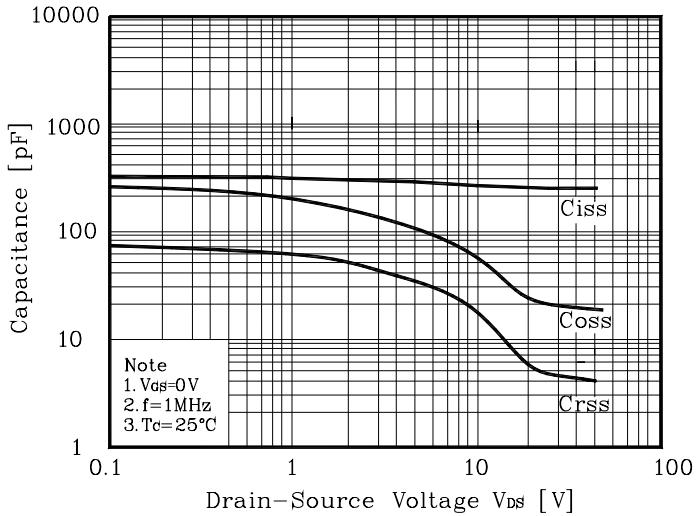
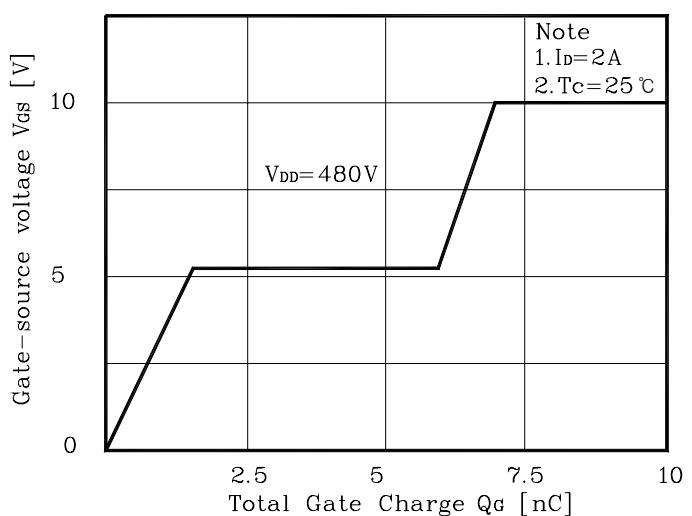


Fig. 6 V_{GS} - Q_G



Electrical Characteristic Curves

Fig. 7 V_{DSS} - T_J

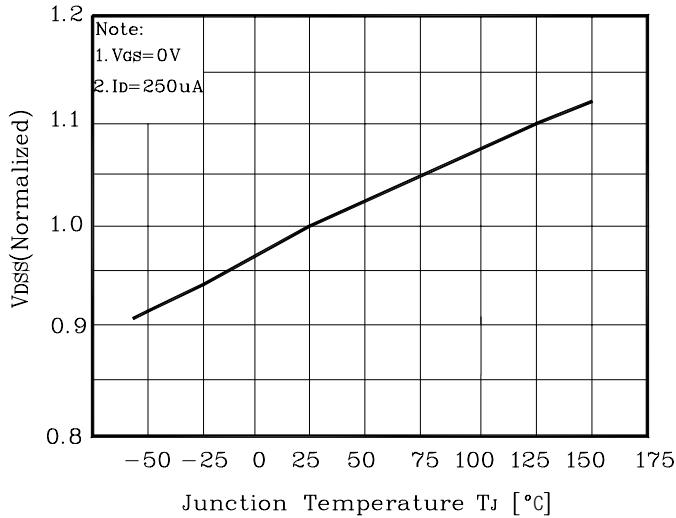


Fig. 8 $R_{DS(on)}$ - T_J

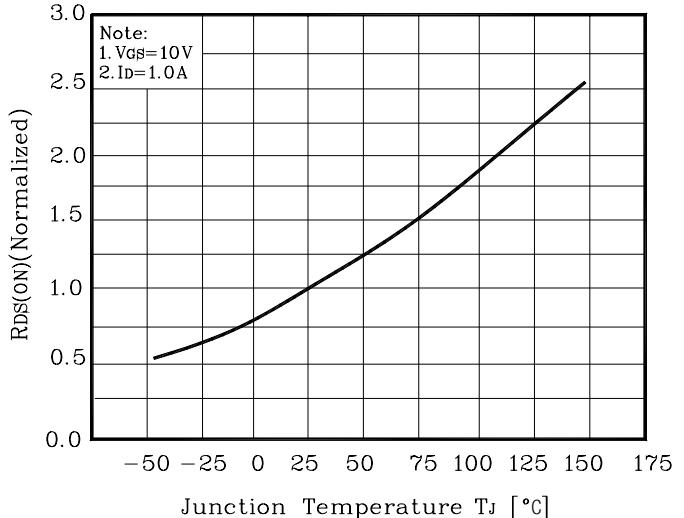


Fig. 9 I_D - T_c

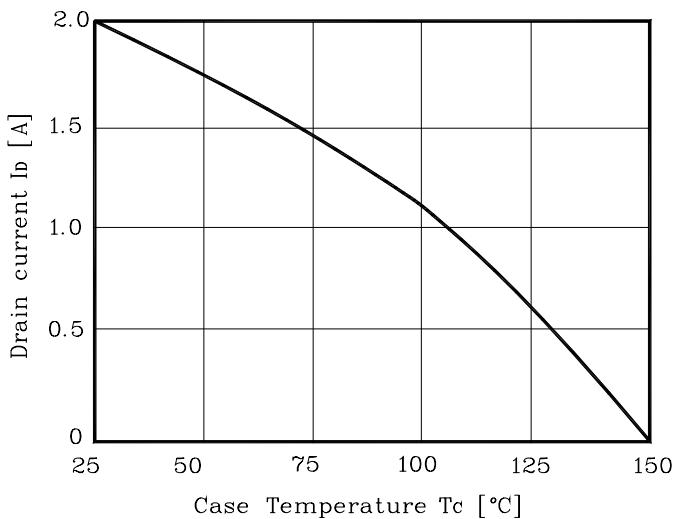


Fig. 10 Safe Operating Area

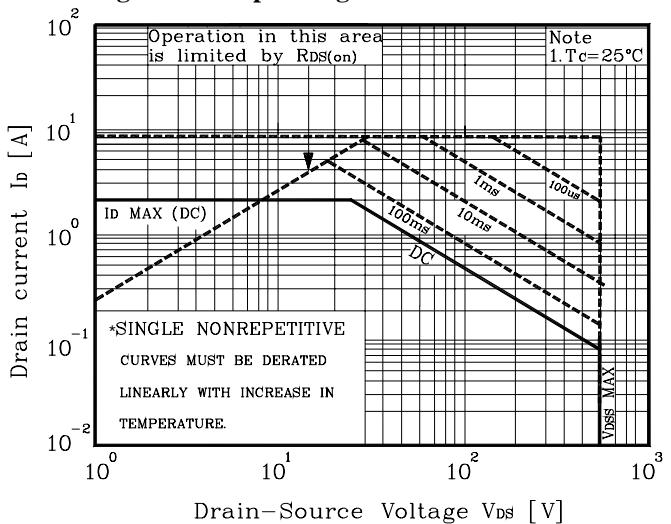


Fig. 11 Gate Charge Test Circuit & Waveform

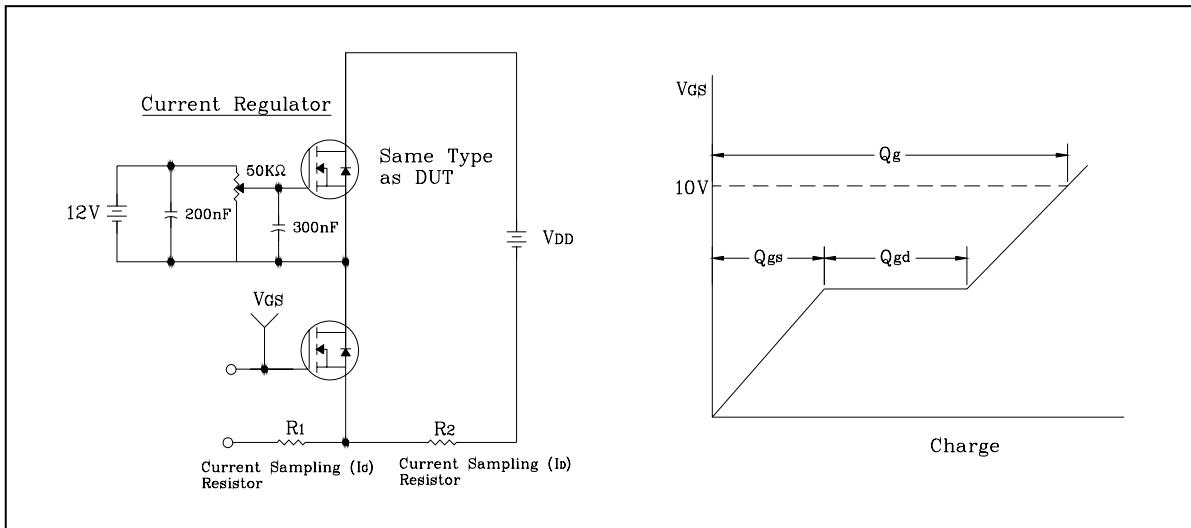


Fig. 12 Resistive Switching Test Circuit & Waveform

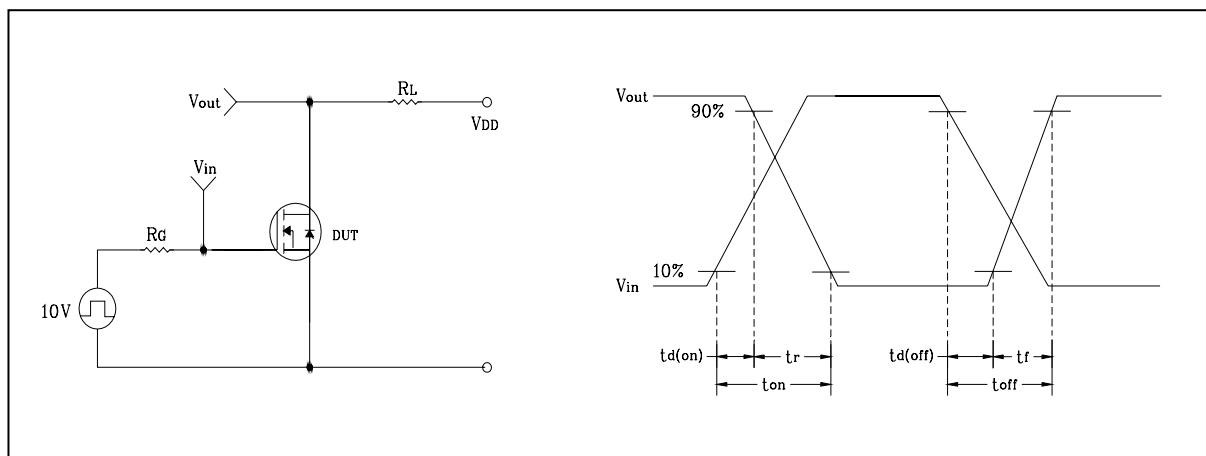


Fig. 13 E_{AS} Test Circuit & Waveform

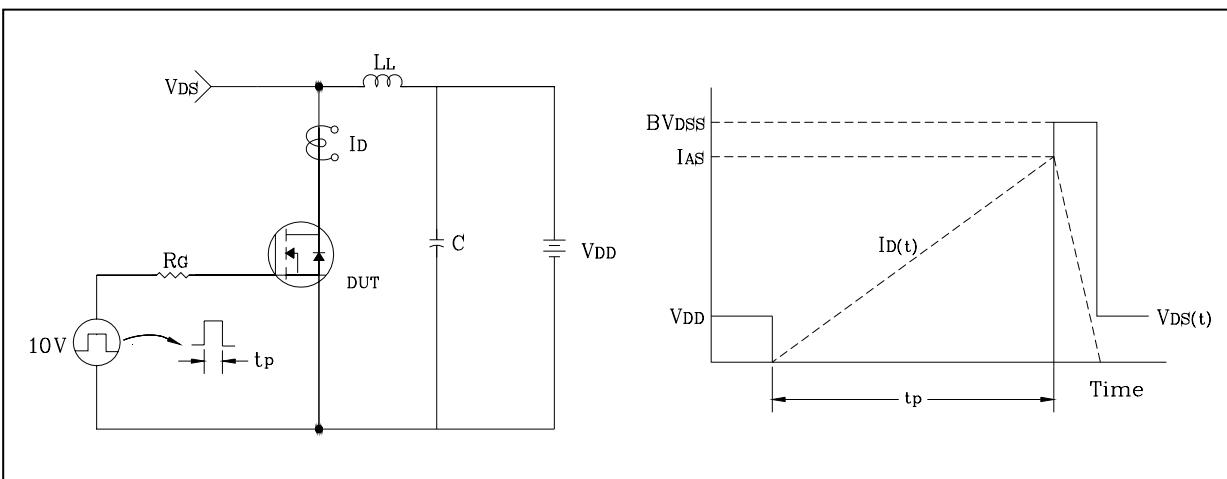
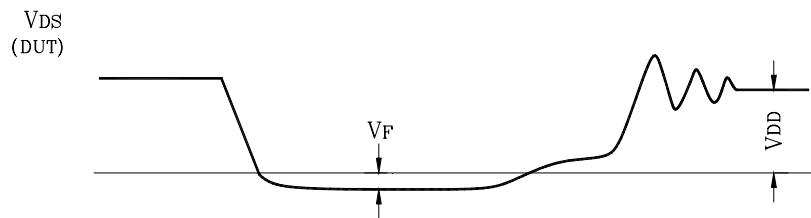
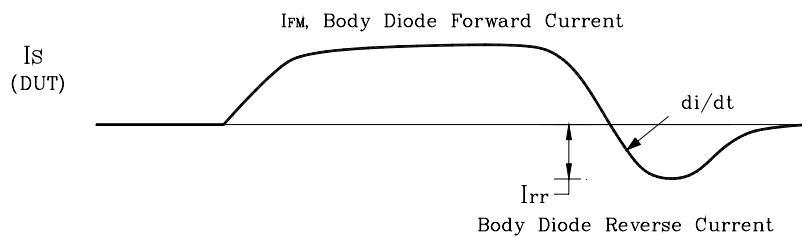
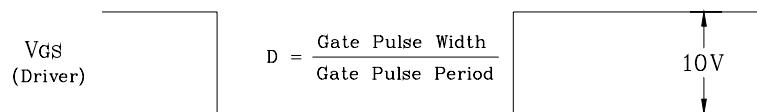
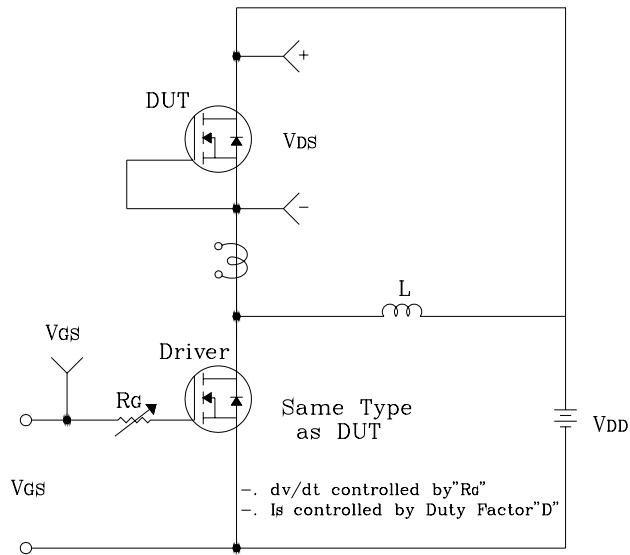
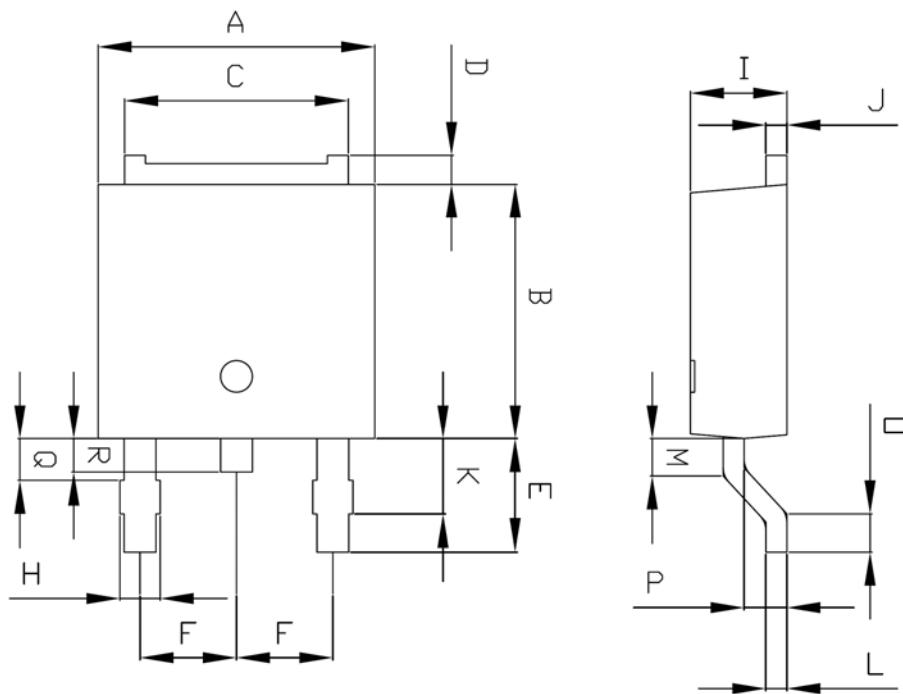


Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform



Outline Dimension

SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	6.40	6.60	6.80	
B	5.90	6.10	6.30	
C	5.04	5.34	5.64	
D	0.50	0.70	0.90	
E	2.50	2.70	2.90	
F	2.10	2.30	2.50	
H	0.96 MAX			
I	2.20	2.30	2.40	
J	0.40	0.50	0.60	
K	1.60	1.80	2.00	
L	0.40	0.50	0.60	
M	0.81	0.91	1.01	
O	0.80	0.90	1.00	
P	0.90	1.00	1.10	
Q	0.95 MAX			
R	0.60	0.80	1.00	

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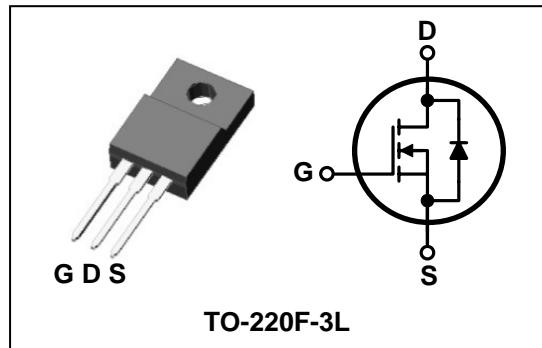
Features

- High Voltage: $BV_{DSS}=600V$ (Min.)
- Low C_{rss} : $C_{rss}=3.4\text{pF}$ (Typ.)
- Low gate charge : $Q_g=7.0\text{nC}$ (Typ.)
- Low $R_{DS(on)}$: $R_{DS(on)}=4.7\Omega$ (Max.)

Ordering Information

Type No.	Marking	Package Code
SMK0260F	SMK0260	TO-220F-3L

PIN Connection



Absolute maximum ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol		Rating	Unit
Drain-source voltage	V_{DSS}		600	V
Gate-source voltage	V_{GSS}		± 30	V
Drain current (DC) *	I_D	$T_C=25^\circ\text{C}$	2.0	A
		$T_C=100^\circ\text{C}$	1.35	A
Drain current (Pulsed) *	I_{DM}		8.0	A
Drain power dissipation	P_D		23	W
Avalanche current (Single) ②	I_{AS}		2.0	A
Single pulsed avalanche energy ②	E_{AS}		130	mJ
Avalanche current (Repetitive) ①	I_{AR}		2.0	A
Repetitive avalanche energy ①	E_{AR}		5.6	mJ
Junction temperature	T_J		150	$^\circ\text{C}$
Storage temperature range	T_{stg}		-55~150	$^\circ\text{C}$

* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max	Unit
Thermal resistance	$R_{th(J-C)}$	-	5.5	$^\circ\text{C}/\text{W}$
	$R_{th(J-A)}$	-	62.5	

Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$I_D=250 \mu\text{A}, V_{GS}=0\text{V}$	600	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$I_D=250 \mu\text{A}, V_{GS} = V_{DS}$	2.0	-	4.0	V
Drain-source cut-off current	I_{DSS}	$V_{DS}=600\text{V}, V_{GS}=0\text{V}$	-	-	1	μA
Gate leakage current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$	-	-	± 100	nA
Drain-source on-resistance ⁽⁴⁾	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=1.0\text{A}$	-	3.9	4.7	Ω
Forward transfer conductance ⁽⁴⁾	g_{fs}	$V_{DS}=10\text{V}, I_D=1.0\text{A}$	-	5	-	S
Input capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$ $f=1 \text{ MHz}$	-	250	334	pF
Output capacitance	C_{oss}		-	20	27	
Reverse transfer capacitance	C_{rss}		-	3.4	4.6	
Turn-on delay time	$t_{d(\text{on})}$	$V_{DD}=300\text{V}, I_D=2.0\text{A}$ $R_G=25\Omega$	-	9	-	ns
Rise time	t_r		-	25	-	
Turn-off delay time	$t_{d(\text{off})}$		-	24	-	
Fall time	t_f		-	28	-	
Total gate charge	Q_g	$V_{DS}=480\text{V}, V_{GS}=10\text{V}$ $I_D=2.0\text{A}$	-	7.0	9.5	nC
Gate-source charge	Q_{gs}		-	1.5	-	
Gate-drain charge	Q_{gd}		-	4.7	-	

Source-Drain Diode Ratings and Characteristics ($T_c=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Source current (DC)	I_S	Integral reverse diode in the MOSFET	-	-	2.0	A
Source current (Pulsed) ⁽¹⁾	I_{SP}		-	-	8.0	
Forward voltage ⁽⁴⁾	V_{SD}	$V_{GS}=0\text{V}, I_S=2.0\text{A}$	-	-	1.4	V
Reverse recovery time	t_{rr}	$I_S=2.0\text{A}, V_{GS}=0\text{V}$ $dI_S/dt=100\text{A}/\mu\text{s}$	-	230	-	ns
Reverse recovery charge	Q_{rr}		-	1.0	-	μC

Note :

① Repetitive rating : Pulse width limited by maximum junction temperature

② $L=59.5\text{mH}, I_{AS}=2.0\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$, Starting $T_J = 25^\circ\text{C}$

③ Pulse Test : Pulse width $\leq 300 \mu\text{s}$, Duty cycle $\leq 2\%$

④ Essentially independent of operating temperature

Electrical Characteristic Curves

Fig. 1 I_D - V_{DS}

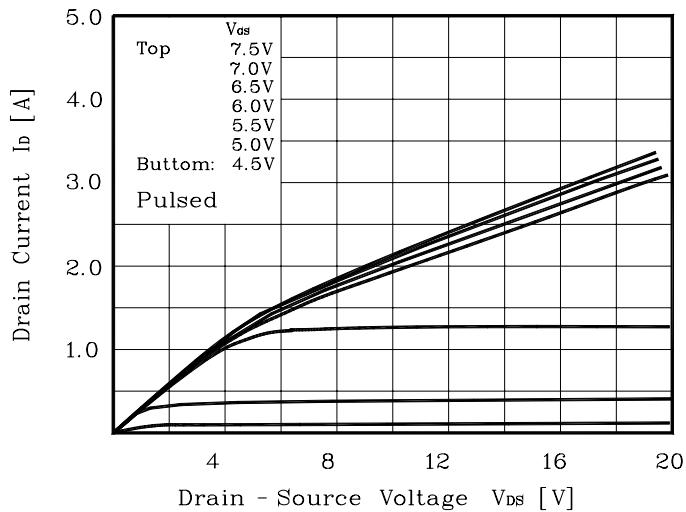


Fig. 2 I_D - V_{GS}

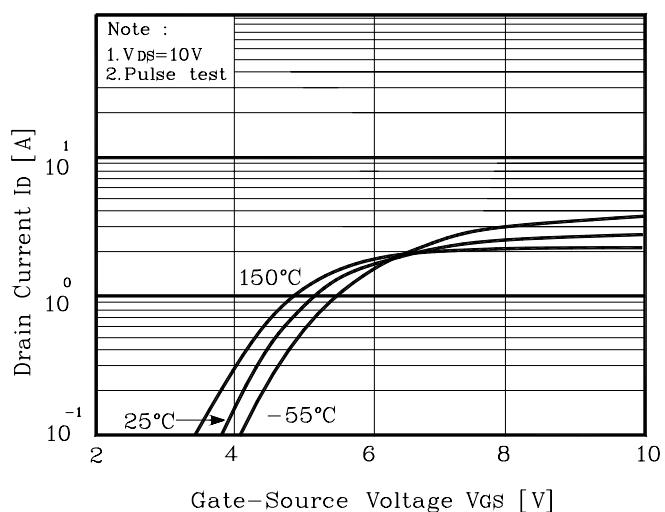


Fig. 3 $R_{DS(on)}$ - I_D

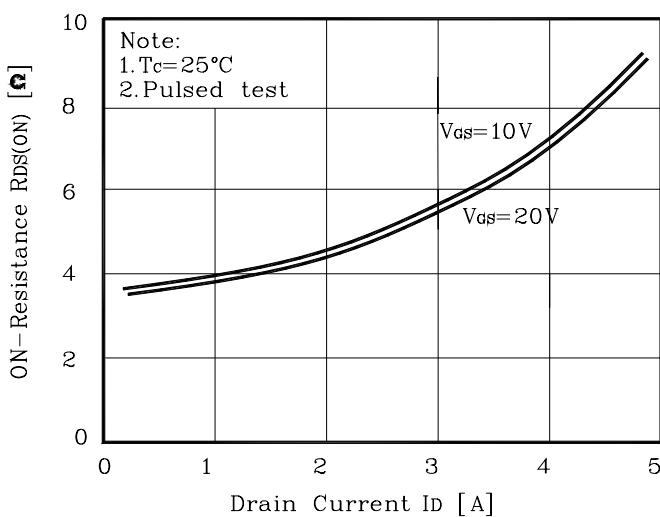


Fig. 4 I_S - V_{SD}

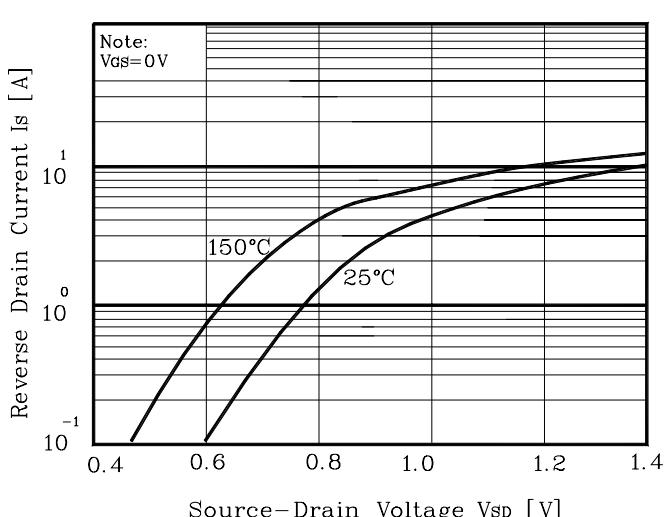


Fig. 5 Capacitance - V_{DS}

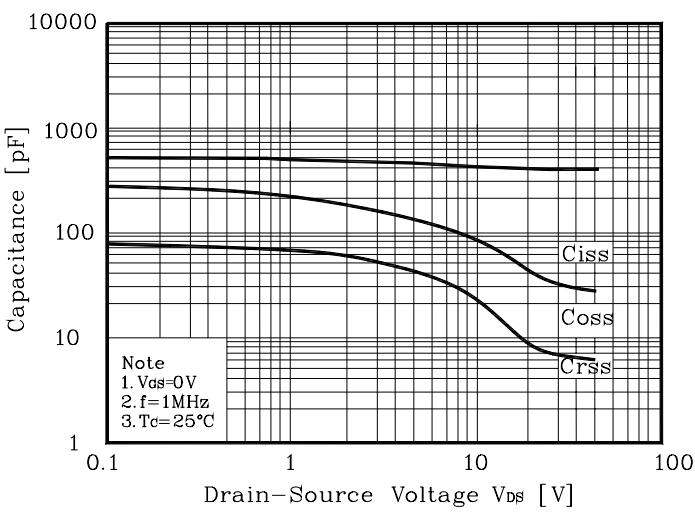
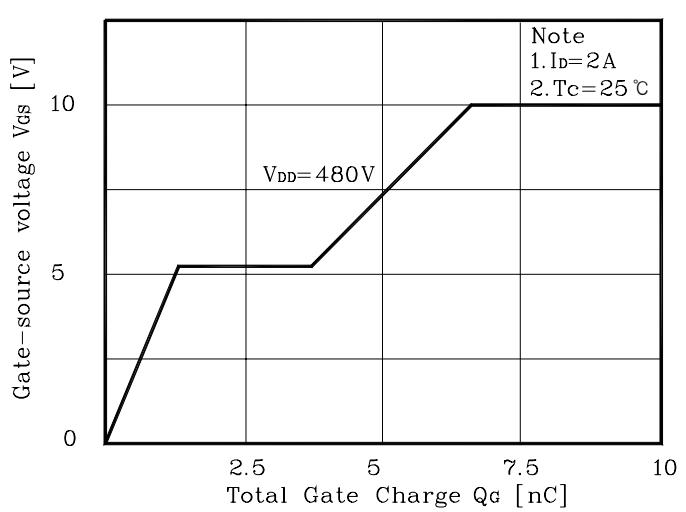


Fig. 6 V_{GS} - Q_G



Electrical Characteristic Curves

Fig. 7 V_{DSS} - T_J

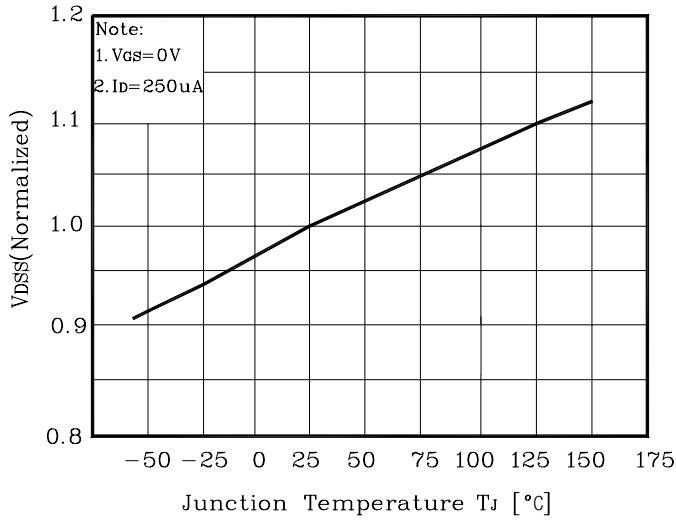


Fig. 8 $R_{DS(on)}$ - T_J

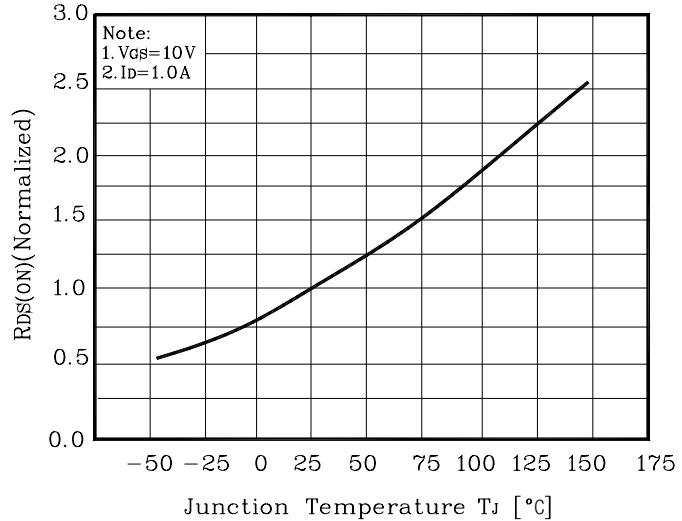


Fig. 9 I_D - T_C

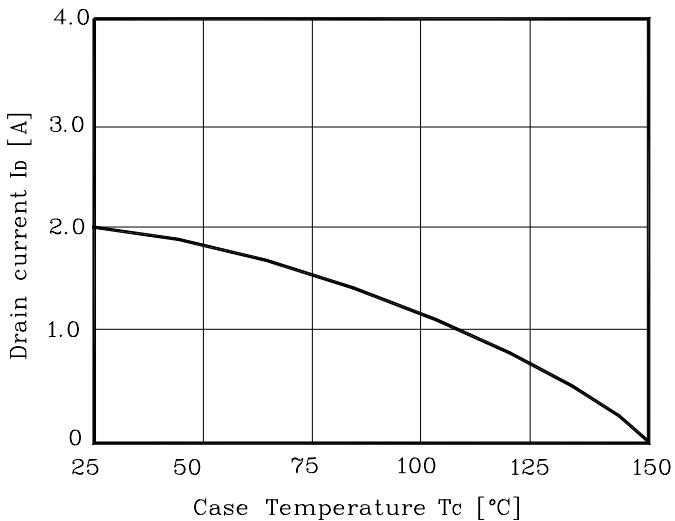


Fig. 10 Safe Operating Area

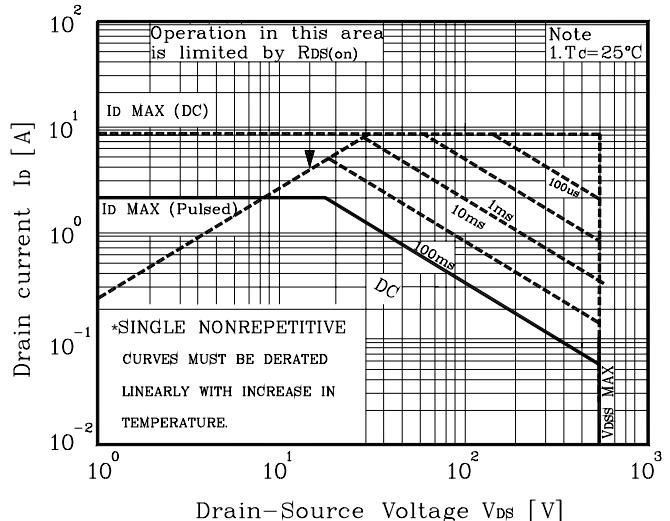


Fig. 11 Gate Charge Test Circuit & Waveform

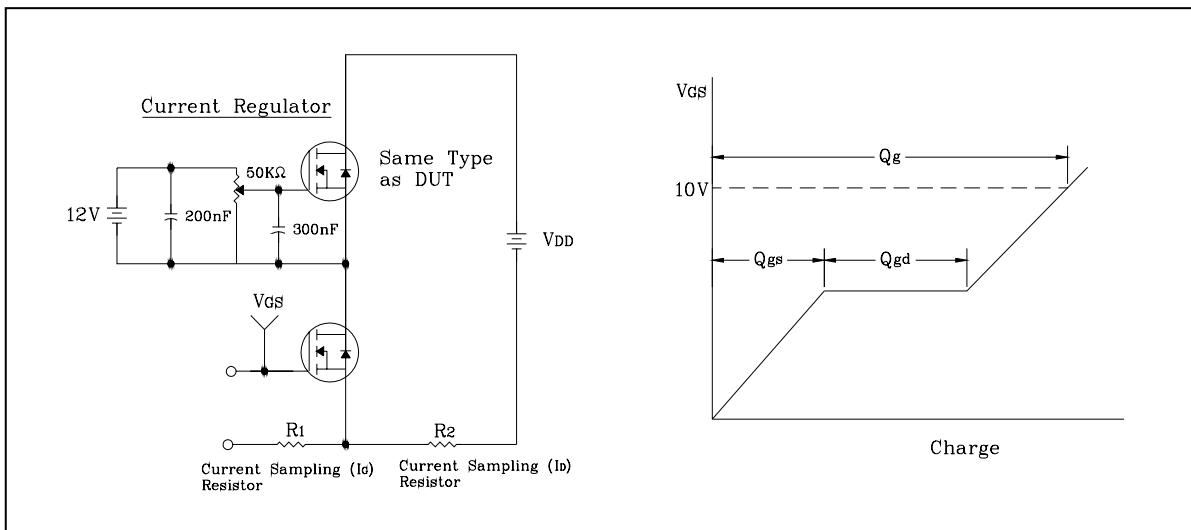


Fig. 12 Resistive Switching Test Circuit & Waveform

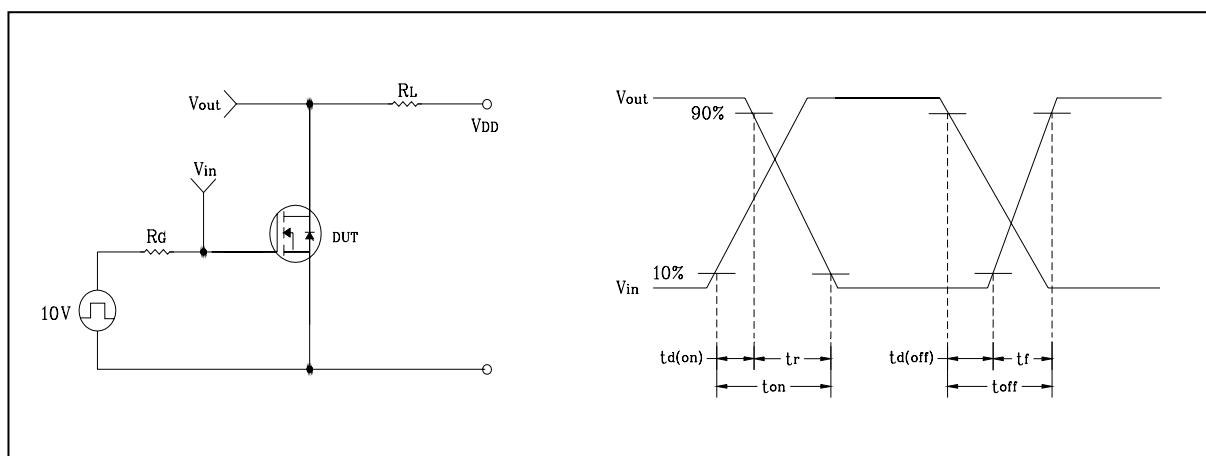


Fig. 13 E_{AS} Test Circuit & Waveform

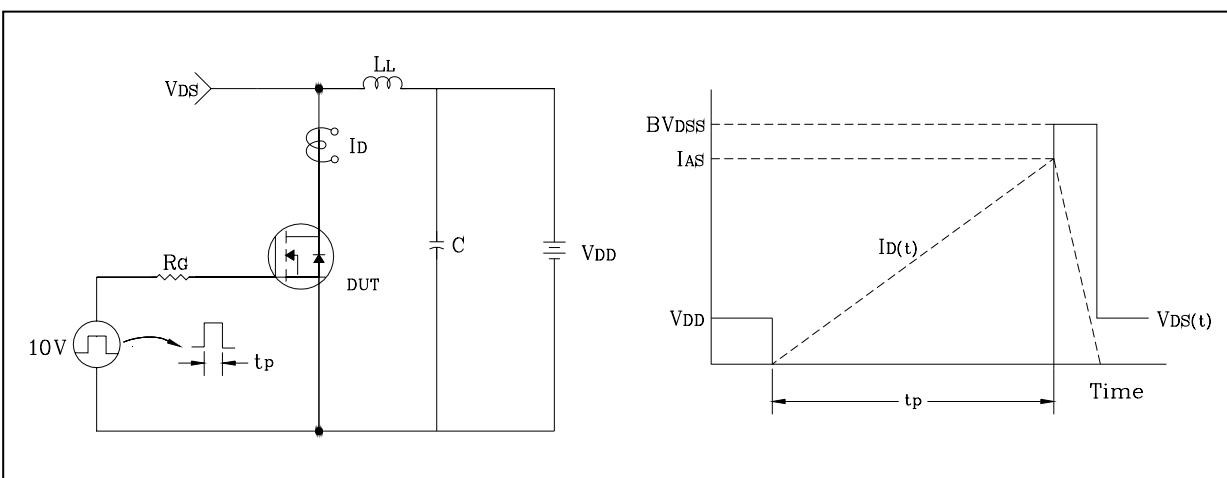
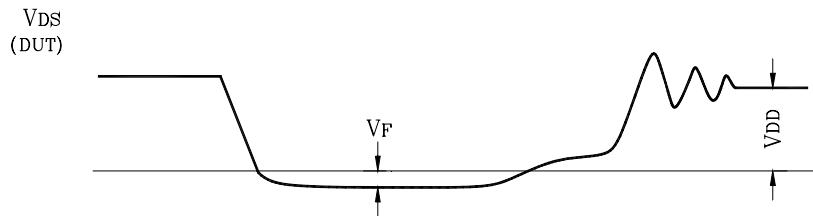
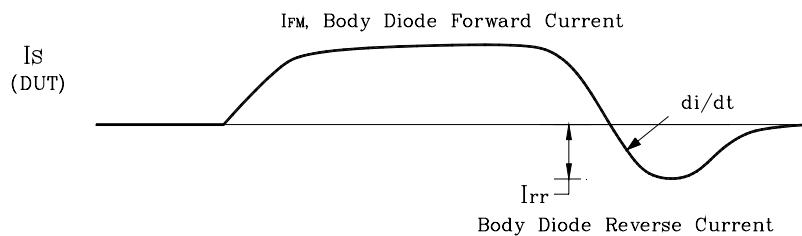
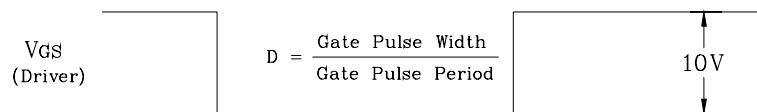
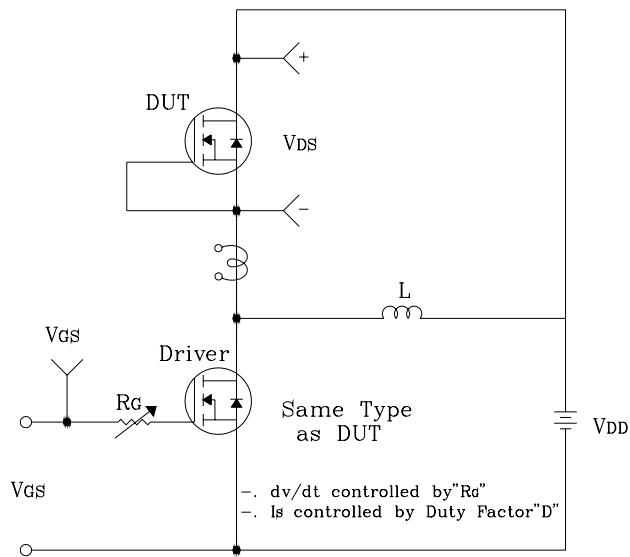
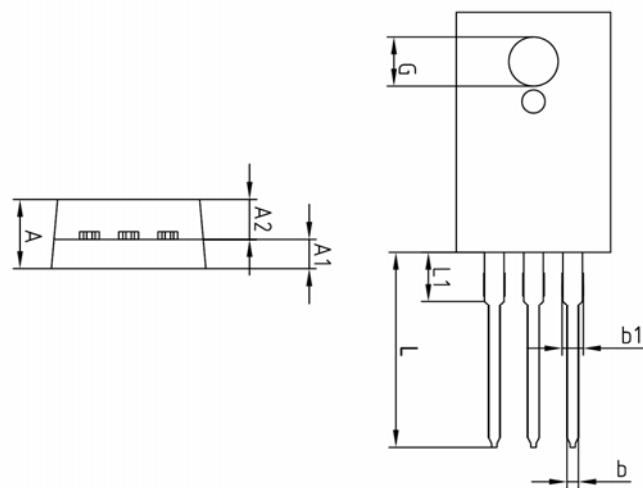
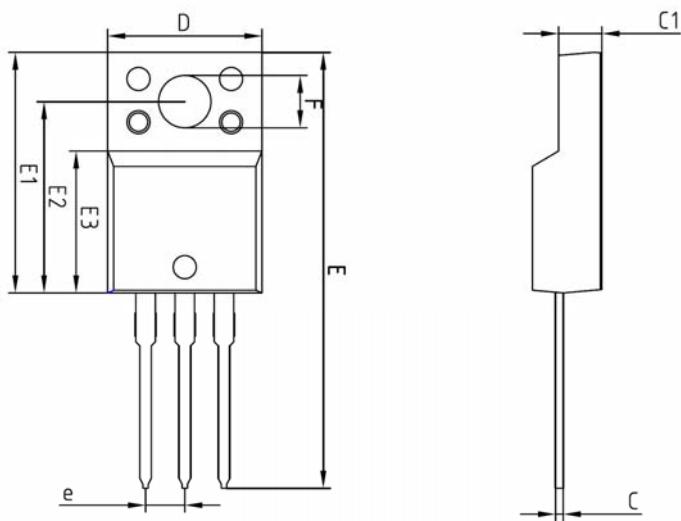


Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform



Outline Dimension

SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	—	—	4.60	
A1	2.45	2.50	2.55	
A2	1.95	2.00	2.05	
b	0.65	0.75	0.85	
b1	1.07	1.27	1.47	
C	0.40	0.50	0.60	
C1	2.70	2.80	2.90	
D	9.90	10.00	10.10	
E	28.00	—	28.60	
E1	15.50	15.60	15.70	
E2	12.30	12.40	12.50	
E3	9.15	9.20	9.25	
F	3.30	3.40	3.50	
G	3.10	3.20	3.30	
e	—	2.54 BSC	—	
L	12.40	—	13.00	
L1	—	3.46 BSC	—	

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Specifications mentioned in this publication are subject to change without notice.

SWITCHING REGULATOR APPLICATIONS

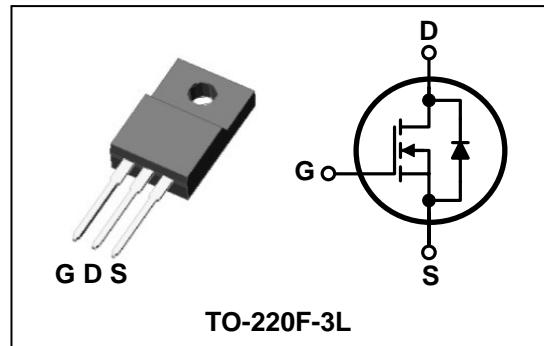
Features

- High Voltage: $BV_{DSS}=700V$ (Min.)
- Low C_{rss} : $C_{rss}=6.0fF$ (Typ.)
- Low gate charge : $Q_g=7.2nC$ (Typ.)
- Low $R_{DS(on)}$: $R_{DS(on)}=6.3\Omega$ (Max.)

Ordering Information

Type No.	Marking	Package Code
SMK0270F	SMK0270	TO-220F-3L

PIN Connection



Absolute maximum ratings ($T_c=25^\circ C$ unless otherwise noted)

Characteristic	Symbol	Rating	Unit
Drain-source voltage	V_{DSS}	700	V
Gate-source voltage	V_{GSS}	± 30	V
Drain current (DC) *	I_D	$T_c=25^\circ C$	A
		$T_c=100^\circ C$	A
Drain current (Pulsed) *	I_{DM}	8.0	A
Drain power dissipation	P_D	25	W
Avalanche current (Single) ②	I_{AS}	2.0	A
Single pulsed avalanche energy ②	E_{AS}	41	mJ
Avalanche current (Repetitive) ①	I_{AR}	2.0	A
Repetitive avalanche energy ①	E_{AR}	1.8	mJ
Junction temperature	T_J	150	$^\circ C$
Storage temperature range	T_{stg}	-55~150	$^\circ C$

* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max	Unit
Thermal resistance	Junction-case	$R_{th(J-C)}$	-	$^\circ C/W$
	Junction-ambient	$R_{th(J-A)}$	-	

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$I_D=250 \mu\text{A}, V_{GS}=0\text{V}$	700	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$I_D=250 \mu\text{A}, V_{GS}=V_{DS}$	2.0	-	4.0	V
Drain-source cut-off current	I_{DSS}	$V_{DS}=700\text{V}, V_{GS}=0\text{V}$	-	-	1	μA
Gate leakage current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$	-	-	± 100	nA
Drain-source on-resistance ⁽⁴⁾	$R_{\text{DS(on)}}$	$V_{GS}=10\text{V}, I_D=1.0\text{A}$	-	4.8	6.3	Ω
Forward transfer conductance ⁽⁴⁾	g_{fs}	$V_{DS}=10\text{V}, I_D=1.0\text{A}$	-	2.5	-	S
Input capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$ $f=1 \text{ MHz}$	-	395	494	pF
Output capacitance	C_{oss}		-	32	41	
Reverse transfer capacitance	C_{rss}		-	6.0	8.0	
Turn-on delay time	$t_{d(\text{on})}$	$V_{DD}=300\text{V}, I_D=2.0\text{A}$ $R_G=25\Omega$	-	22	-	ns
Rise time	t_r		-	10.5	-	
Turn-off delay time	$t_{d(\text{off})}$		-	7	-	
Fall time	t_f		-	10.5	-	
Total gate charge	Q_g	$V_{DS}=560\text{V}, V_{GS}=10\text{V}$ $I_D=2.0\text{A}$	-	7.2	9.0	nC
Gate-source charge	Q_{gs}		-	2.5	-	
Gate-drain charge	Q_{gd}		-	1.5	-	

Source-Drain Diode Ratings and Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Source current (DC)	I_S	Integral reverse diode in the MOSFET	-	-	2.0	A
Source current (Pulsed) ⁽¹⁾	I_{SP}		-	-	8.0	
Forward voltage ⁽⁴⁾	V_{SD}	$V_{GS}=0\text{V}, I_S=2.0\text{A}$	-	-	1.4	V
Reverse recovery time	t_{rr}	$I_S=2.0\text{A}, V_{GS}=0\text{V}$ $dI_S/dt=100\text{A}/\mu\text{s}$	-	260	-	ns
Reverse recovery charge	Q_{rr}		-	1.09	-	

Note :

- ① Repetitive rating : Pulse width limited by maximum junction temperature
- ② $L=19\text{mH}, I_{AS}=2.0\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$
- ③ Pulse Test : Pulse width $\leq 300 \mu\text{s}$, Duty cycle $\leq 2\%$
- ④ Essentially independent of operating temperature

Electrical Characteristic Curves

Fig. 1 I_D - V_{DS}

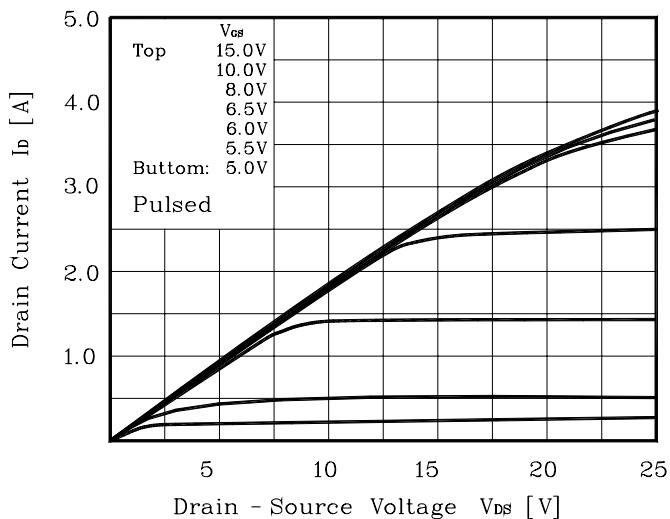


Fig. 2 I_D - V_{GS}

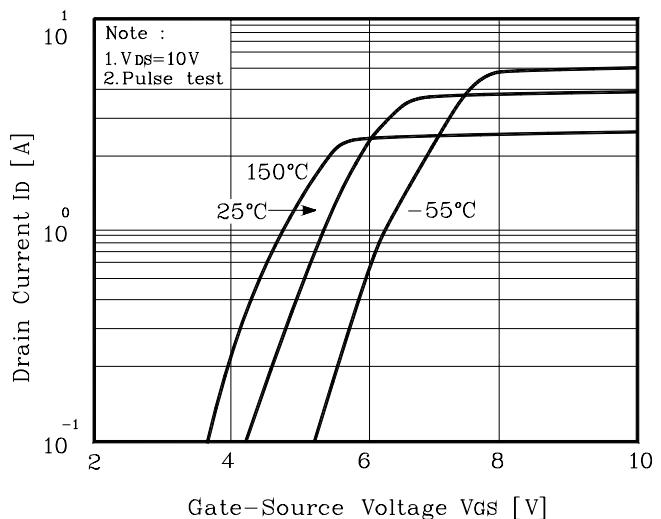


Fig. 3 $R_{DS(on)}$ - I_D

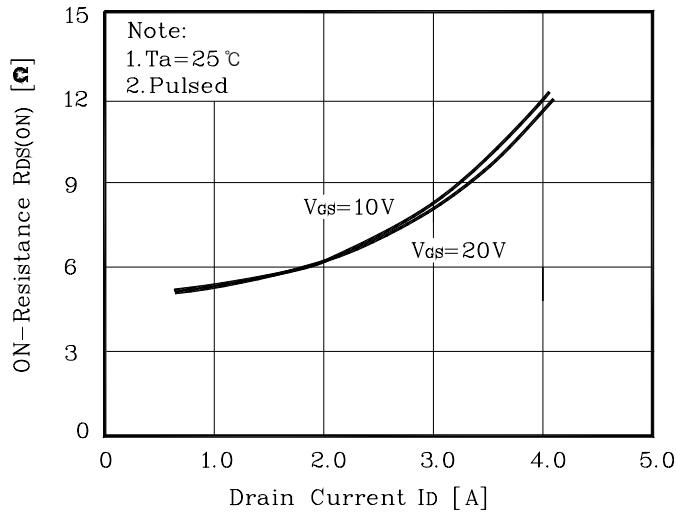


Fig. 4 I_S - V_{SD}

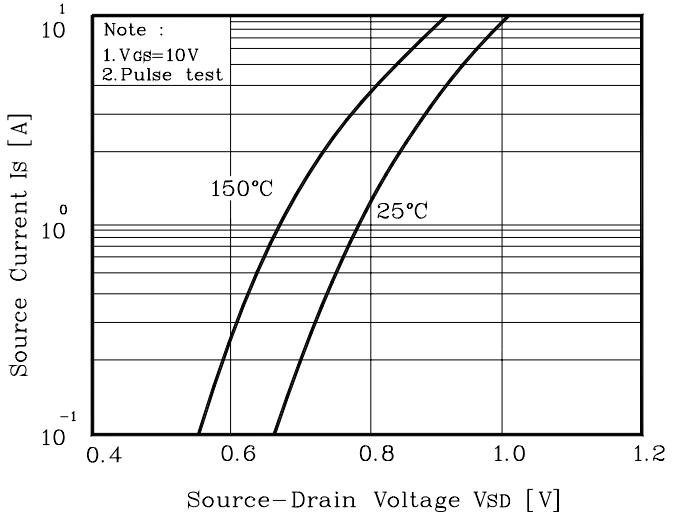


Fig. 5 Capacitance - V_{DS}

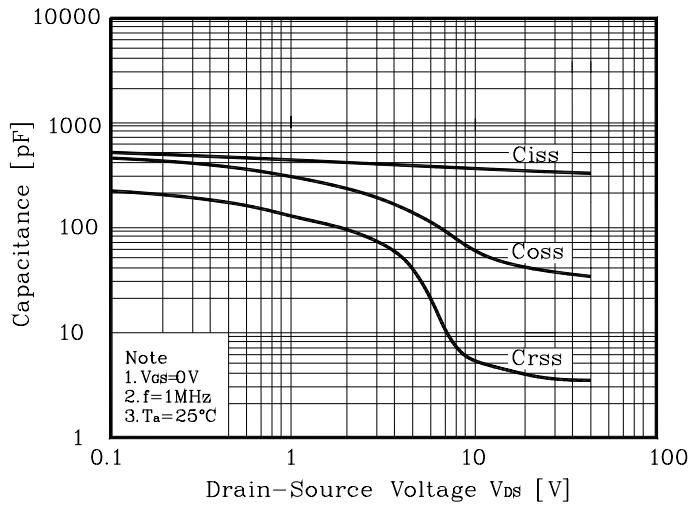


Fig. 6 V_{GS} - Q_G

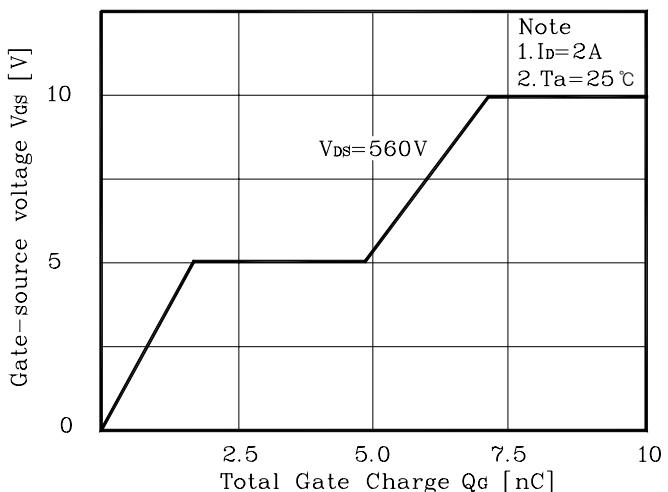


Fig. 7 V_{DSS} - T_J

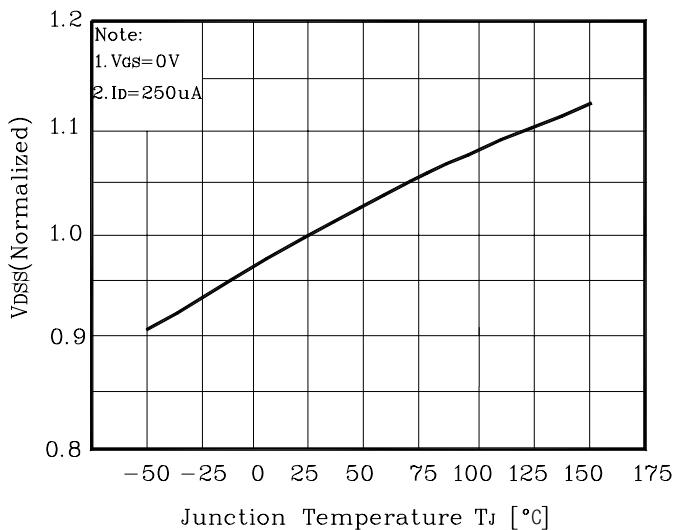


Fig. 8 $R_{DS(on)}$ - T_J

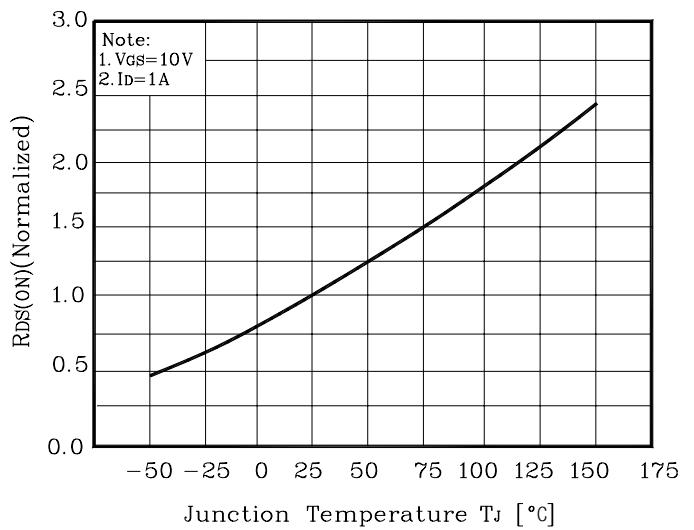


Fig. 9 I_D - T_a

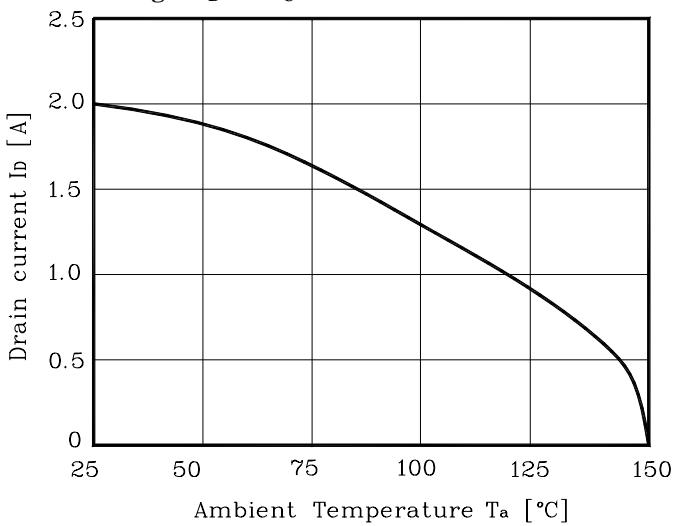


Fig. 10 Safe Operating Area

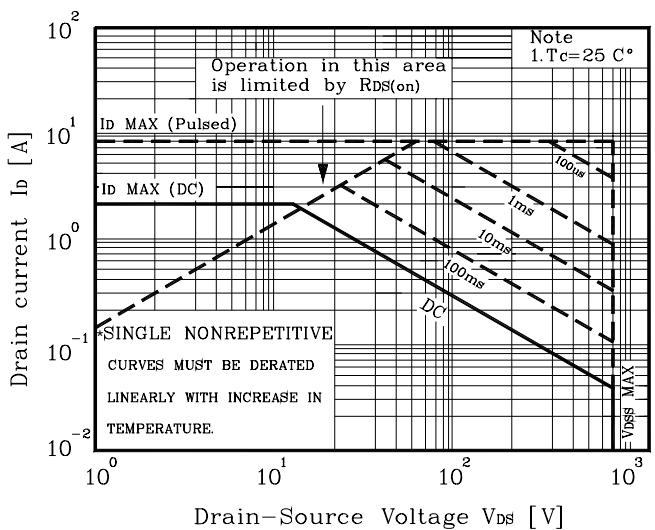


Fig. 11 Gate Charge Test Circuit & Waveform

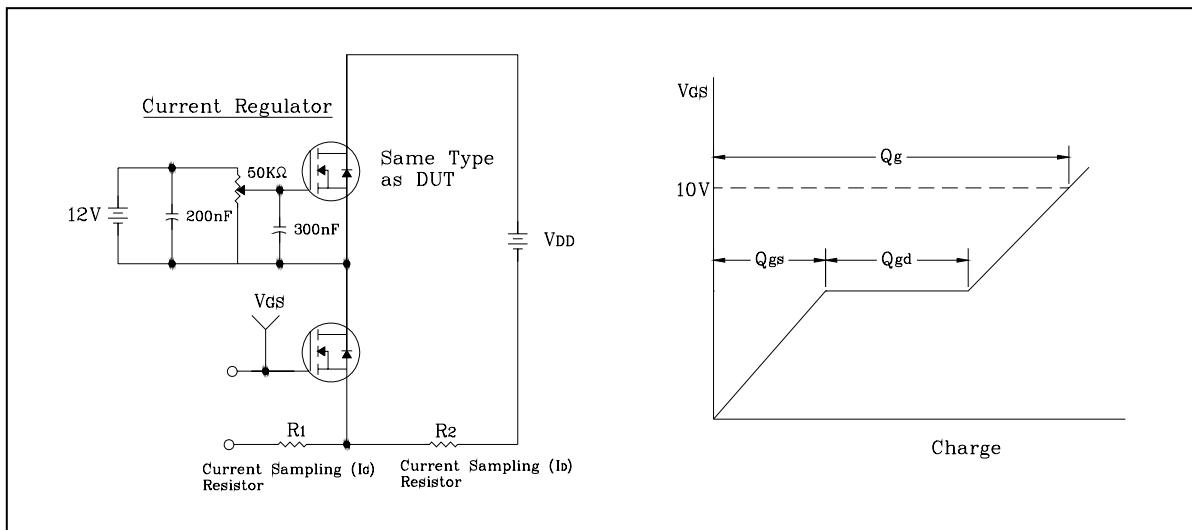


Fig. 12 Resistive Switching Test Circuit & Waveform

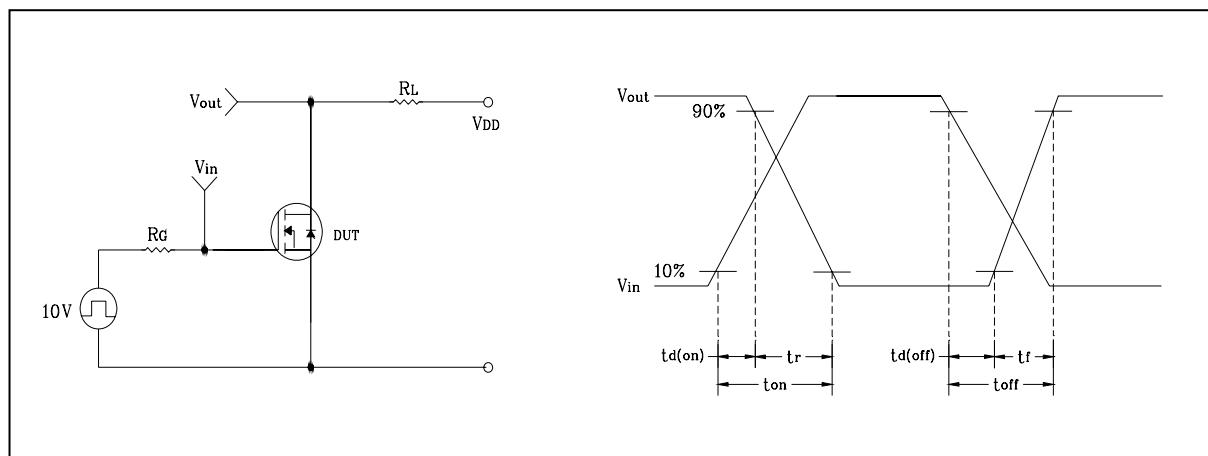


Fig. 13 E_{AS} Test Circuit & Waveform

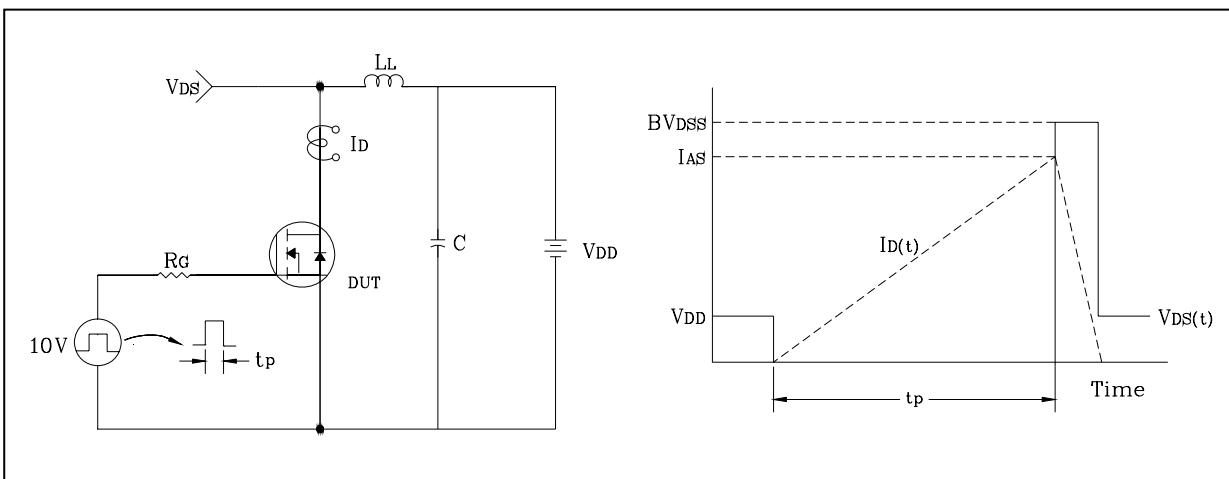
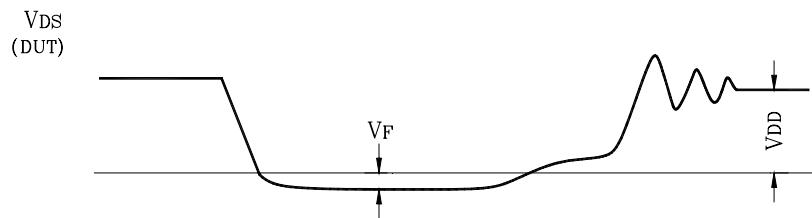
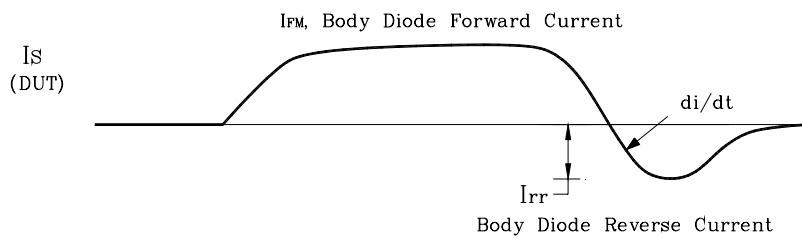
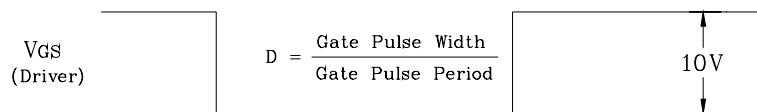
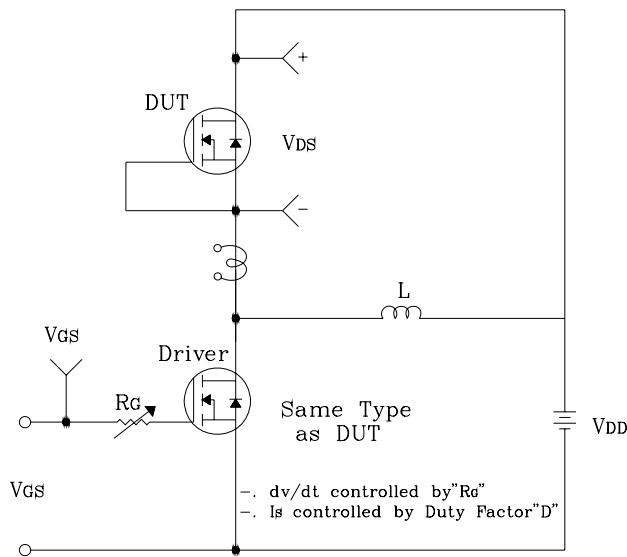
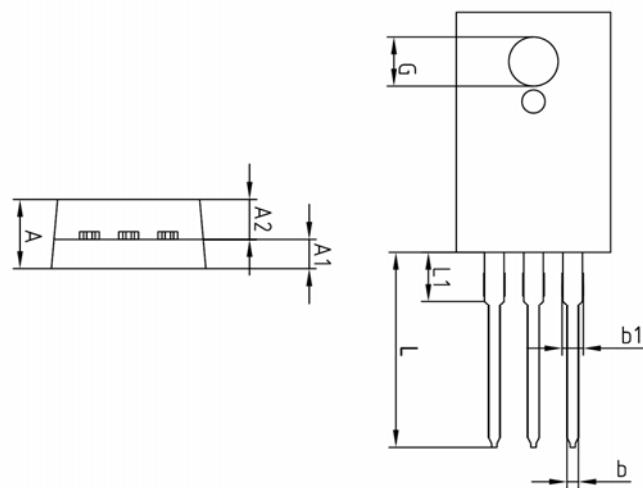
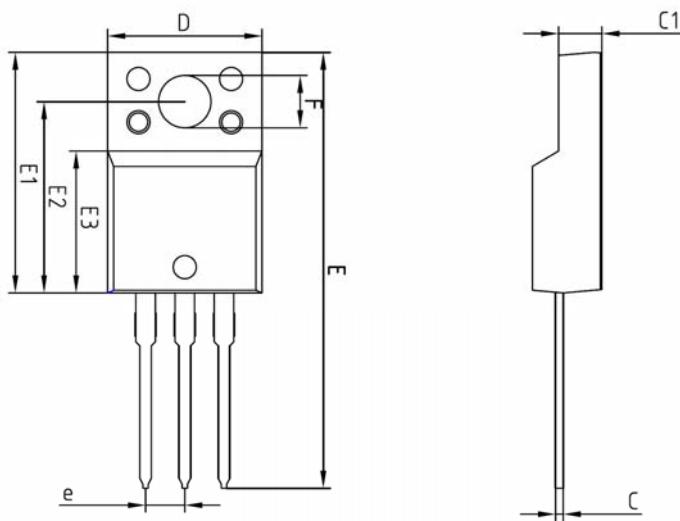


Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform



Outline Dimension

SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	—	—	4.60	
A1	2.45	2.50	2.55	
A2	1.95	2.00	2.05	
b	0.65	0.75	0.85	
b1	1.07	1.27	1.47	
C	0.40	0.50	0.60	
C1	2.70	2.80	2.90	
D	9.90	10.00	10.10	
E	28.00	—	28.60	
E1	15.50	15.60	15.70	
E2	12.30	12.40	12.50	
E3	9.15	9.20	9.25	
F	3.30	3.40	3.50	
G	3.10	3.20	3.30	
e	—	2.54 BSC	—	
L	12.40	—	13.00	
L1	—	3.46 BSC	—	

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